

Certificate of non-use of The Controlled Substances

Company name	Littelfuse, Inc
Product Covered	Thyristor SOT-223 Package
Issue Date	April 27, 2011
2002/95/EC)-restricted s	by Littelfuse, Inc., that there is neither RoHS (EU Directive ubstance, nor such use, for materials to be used for unit parts, for ials, and for additives and the like in the manufacturing processes.
•	fuse, Inc., that the products listed in this report do not contain Halogens ged per widely accepted industrial guidelines.
for unit parts, the packing	ported to you that the parts and sub-materials, the materials to be used /packaging materials, and the additives and the like in the manufacturing sed of the following components.
	Issued by
	< Koichiro Yoshimoto, Senior Product Engineer, Littelfuse, Inc.>
(1) Parts, sub-materials a	and unit parts
	ers Thyristor SOT-223 Package, supplied by Littelfuse, LP. Please see f products covered.
<materials used=""></materials>	
Please see tab	e 1 on page 3 and table 2 on page 4 of this document.
(2) The analysis result of	on all measurable substances
Please see ann	ex 1 through 8 attached to this document.
Remarks :	

1. Pb (lead) contained in die attach (item 3) and passivation glass in wafer (item 6) are categorized as exempt in RoHS Annex 5 & 7.

Please refer to Annex 7 of this report for the extract of the applicable exemptions of RoHS (EU Directive 2002/95/EC)

April 27, 2011 Littelfuse, Inc. Page 1 of 3



Table 1: Littelfuse Part Number covered by this report

Stan	Standard (Catalog) Part Number				
L0103DTRP	L0109DTRP	S4X8TSRP	Any Special P/N which		
L0103DTRP4	L0109DTRP4	S4X8TS1RP	has base standard P/N		
L0103MTRP	L0109MTRP	S4X8TS2RP	listed in this table.		
L0103MTRP4	L0109MTRP4	S402TSRP	S940S6X8TSRP		
L0103NTRP	L0109NTRP	S6X8TSRP			
L0103NTRP4	L0109NTRP4	S6X8TS1RP			
L0107DTRP		S6X8TS2RP			
L0107DTRP4	LX803DTRP	S602TSRP			
L0107MTRP	LX803MTRP	S8X8TSRP			
L0107MTRP4	LX807DTRP	S8X8TS1RP			
L0107NTRP	LX807MTRP	S8X8TS2RP			
L0107NTRP4					

Table 2: Homogeneous Material Used

#	Description	Name of Material	Туре	Analysis data			
1	Lead finish	Matte-Tin	metal	annex 1			
2	Molding compound	Epoxy resin	plastic	annex 2			
3	Die attach	solder	metal	annex 3	Pb for this solder application is exempted by RoHS Annex 7. Please refer to Annex 7 of this report for the RoHS exemption.		
4	Die bonding wire	Gold	metal	annex 4			
5	Lead frame	copper alloy	metal	annex 5			
		silicon	metal	annex 6			
6	6 Silicon die	aluminum	metal		Pb in the report is from passivation glass and is exempted by RoHS Annex 5. Please refer to Annex 7 of this report for the		
		glass	glass		RoHS exemption.		

April 27, 2011 Littelfuse, Inc. Page 2 of 3



Table 3: RoHS-regulated substance in raw materials

Table 5. K	J						
Components	Analysis Result						
	Cd Cadmium	Cr Chromium	Hg Mercury	Pb Lead	PBB	PBDE	TOTAL HALOGEN
As Component Total (Typical Values)	< 2ppm	< 2ppm	< 2ppm	<2 ppm* ¹ (0.3% ²)	< 5 ppm	< 5 ppm	< 112 ppm
Outside lead finish (Matte-Tin plating) See Annex 1 for the detail.	< 2ppm	< 2ppm	< 2ppm	49ppm	< 5ppm	< 5ppm	
Epoxy Resin compound (mixture of resin, filler and fire retardant) See Annex 2 for the detail.	< 2ppm	< 2ppm	< 2ppm	< 2ppm	< 5ppm	< 5ppm	112ppm
Die Attach Solder (Solder) See Annex 3 for the detail.	< 2ppm	< 2ppm	< 2ppm	92.5% ^{*3}	< 5ppm	< 5ppm	
Die-bonding Wire (Gold wire) See Annex 4 for the detail.	< 2ppm	< 2ppm	< 2ppm	< 2ppm	< 5ppm	< 5ppm	< 50ppm
Lead frame (Copper Alloy C194) See Annex 5 for the detail.	< 2ppm	< 2ppm	< 2ppm	16ppm	< 5ppm	< 5ppm	
Silicon Die (Silicon + Metal electrode + passivation) See Annex 6 for the detail.	< 2ppm	< 2ppm	< 2ppm	1.9 % ^{*3}	< 5ppm	< 5ppm	< 50ppm

Please refer to Annex 7 of this report for the applicable exemptions of RoHS (EU Directive 2002/95/EC)

April 27, 2011 Littelfuse, Inc. Page 3 of 3

^{*1} Less than 2 ppm Pb content overall, excluding Pb from the wafer passivation glass on silicon die.

^{*2} Up to 0.4% of Pb (lead) content overall, including the RoHS-exempted use of Pb

^{*3} Pb (lead) contained in die-attach solder and passivation glass are exempted from restriction by RoHS Annex 5 & 7.



Annex 1: Analysis Result of Outside Lead Plating Material (Page 1 of 5)



Test Report No. LPCI/00919/11 Date: 18/01/2011 Page: 1 of 5

CTS Ref. CTS/11/0153/Success-Crown

CROWN EMPEROR LTD ROOM 2101, HONG KONG TRADE CENTRE 161-7 DES VOEUX ROAD CENTRAL, HONG KONG

The following merchandise was (were) submitted and identified by the client as:

Sample Description : SNTITE 24, 99.95% PURETIN ANODE

Sample Receiving Date : 12/01/2011

Testing Period : 12/01/2011 to 16/01/2011

Test Requested : In accordance with the RoHS Directive 2002/95/EC, and its

amendment directives.

Test Method : Please refer to next page(s).

Test Results : Please refer to next page(s).

Analysts ; Ng Mei Khang & Loi Woan Yee

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CHONG KIEN LEN B.Sc.(HONS) AMIC LAB MANAGER

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SGS Lahoratory Services (M) Sdn. Bhd. No.26 Jalan Anggerik Vanilla 31,63 Kota Kemuning 40,460 Selangor Darul Ehsan, Malaysia (Company No. 63972-44) +6 (03) 5121 2320 | f+6 (03) 5121 9082 | www.sgs.com



Annex 1: Analysis Result of Outside Lead Plating Material (Page 2 of 5)



Test Report No. LPCI/00919/11 Date: 18/01/2011 Page: 2 of 5

CTS Ref. CTS/11/0153/Success-Crown

Test results:

Test Part Description

Sample Description SNTITE-24, 99.95% PURETIN ANODE

RoHS Directive 2002/95/EC

Test Item(s):	Unit	Test Method	Results	<u>MOL</u>
Cadmium(Qd)	mg/kg	With reference to EPA Method 3051A, and performed by ICP-OES	N.D.	2
Lead (Pb)	mg/kg	With reterence to EPA Method 3051A, and performed by ICP-OES	49	2
Mercury (Hg)	rrg/kg	With reference to EPA Method 3051A, and performed by ICP-OES	N.D.	2
Hexavalent Chromium (CrVI)	mg/kg	With reference to EPA Method 3060A & 7196A, and performed by UV-VIS Spectrophotometry	N.D.	2
Sum of PBBs	mg/kg	With reference to EPA Method 35400/35500, and performed by GC-MS	N.D.	-
Monobromobiphenyl	mg/kg	With reference to EPA Method 3540C/3550C, and performed by GC-MS	N.D.	5
Dibromobiphenyl	ту/Кз	With reference to EPA Method 3540C/3550C, and performed by GC-MS	N.D.	5
Tribromobiphanyl	mg/kg	With reference to EPA Method 3540C/3550C, and performed by GC-MS	N.D.	5
Tetrabromobiphenyl	mg/kg	With reference to EPA Method 35400/35500, and performed by GC-MS	N.D.	5
Hexabromobiphenyl	mg/Kg	With reference to EPA Method 35400/35500, and performed by GC-MS	N.D.	5
Pentabromobiphenyl	mą/kg	With reference to EPA Method 3540C/3550C, and performed by GC-MS	N,D.	5
Heptabromobiphenyl	rng/Kg	With reference to EPA Method 35400/35500, and performed by GC-MS	N.D.	5
Octabromoblphenyl	mg/kg	With reference to EPA Method 3540C/3560C, and performed by GC-MS	N.D.	5
Nonabromobiphenyl	mg/kg	With reference to EPA Method 35400/35500. and performed by GC-MS	N.D.	5
Decabromobiphenyl	rig/Kg	With reference to EPA Method 3540C/3550C, and performed by GC-MS	ND.	5

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Annex 1: Analysis Result of Outside Lead Plating Material (Page 3 of 5)



Test Report No. LPCI/00919/11 Date: 18/01/2011 Page: 3 of 5 CTS Ref. CTS/11/0153/Success-Crown

Test Item(s);	Unit	Test Method	Results	MDL
Sum of PBDEs	mg/kg	With reference to EPA Method 3540C/3550C, and performed by GC-MS	N.D.	
Monabromodiphenyl ether	mg√kg	With reference to EPA Method 3540C/3550C, and performed by GC-MS.	N.D.	6
Dibromodiphenyl ether	mg/kg	With reference to EPA Method 3540C/3550C, and performed by GC-MS	N.D.	5
Tribromodiphenyl ether	mg/kg	With reference to EPA Method 3540C/3550C, and performed by GC-MS.	N.D.	6
Tetrabromodiphenyl ether	mg/kg	With reterence to EPA Method 3540C/3550C, and performed by GC-MS	N.D.	60
Pentabromodiphenyl ether	mg/kg	With reference to EPA Method 3540C/3550C, and performed by GC-MS	N.D.	5
Hexabromodiphenyi ether	nng√kg	With reference to EPA Method 3540C/3550C, and performed by GC-MS	N.D.	5
Heptabromodiphenyl ether	mg/kg	With reference to EPA Method 3540C/3550C, and performed by GC-MS	N.D.	5
Octabromodiphenyl ether	mg/kg	With reference to EPA Method 3540C/3550C, and performed by GC-MS	N.D.	5
Nonabromodiphenyl ether	mg/kg	With reference to EPA Method 3540C/3550C ₁ and performed by GC-MS	N.D.	5
Decabromodiphenyl ether##	mg/kg	With reference to EPA Method 3540C/3550C, and performed by GC-MS	N.D	5

(a) mg/kg = ppm; (0.1 wt% = 1000 ppm) (b) N.D. = Not Detected Note:

(c) MDL - Method Detection Limit (d) ## = The exemption of DecaBDE in polymeric application according 2006/717/EC was overruled by the European Court of Justice by its decision of 01.04.2008. Subsequently DecaBDE is Included in the sum of PBDE after 01.07.2008

(e) - = Not regulated

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Annex 1: Analysis Result of Outside Lead Plating Material (Page 4 of 5)



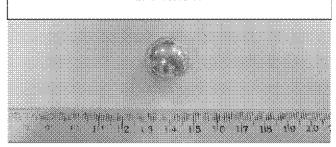
Test Report No. LPCI/00919/11 Date: 18/01/2011 Page: 4 of 5

CTS Ref. CTS/11/0153/Success-Crown

Test Part Description:

Sample Description SNTITE-24, 99.95% PURETIN ANODE

> **CROWN EMPEROR LTD** LPCI/00919/11



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Annex 1: Analysis Result of Outside Lead Plating Material (Page 5 of 5)



Test Report

No. LPCI/00919/11

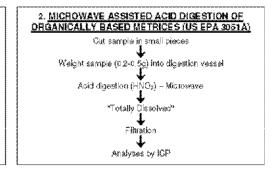
Date: 18/01/2011

Page: 5 of 5

CTS Ref. CTS/11/0153/Success-Crown

1. DETERMINATION OF HEXAVALENT CHROMIUM BY METHOD US EPA 3060 A/7196A Sample Preparation Add colour-developing reagent Addity with H2SO4 Let stand for 5-10 min

Analyses by UV-Spectrophotometer (540 nm)



3. DETERMINATION OF PBB/PBDE WITH GC-MS

Gut sample in small places Weight sample (0.5.4g) into extraction thimble Ultrasonis / Soxhlet Extraction with Toluene Fliter through 0.45 um membrane filter Analyses by GC-MS (with appropriate dilution)

***** End of Report ****

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Annex 2: Analysis Result of Molding Compound (Page 1 of 7)



Test Report No. CANEC1100147901 Date: 17 Jan 2011 Page 1 of 7

HENKEL HUAWEI ELECTRONICS CO.,LTD. SONGTIAO INDUSTRIAL PARK, LIANYUNGANG. JIANGSU, CHINA

The following sample(s) was/were submitted and identified on behalf of the clients as :

Epoxy Moulding Compounds

12938105 - SZ SGS Job No. Tested Sample Information : GR640A-S Date of Sample Received : 13 Jan 2011

Testing Period 13 Jan 2011 - 17 Jan 2011

Test Requested Selected test(s) as requested by client.

Test Method Please refer to next page(s). Test Results Please refer to next page(s).

Conclusion A:Based on the performed tests on submitted sample(s), the results comply

with the RoHS Directive 2002/95/EC and its subsequent amendments.

Signed for and on behalf of SGS-CSTC Ltd.

Annie Liang Approved Signatory

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Annex 2: Analysis Result of Molding Compound (Page 2 of 7)



Test Report No. CANEC1100147901 Date: 17 Jan 2011 Page 2 of 7

Test Results:

ID for specimen 1 : CAN11-001479.001
Description for specimen 1 : Dk-grey material

A:RoHS Directive 2002/95/EC

Test Item(s)	Unit	Test Method (Reference)	Result	MDL	Limit
Cadmium (Cd)	mg/kg	IEC 62321:2008, ICP-OES	N.D.	2	100
Lead (Pb)	mg/kg	IEC 62321:2008, ICP-OES	N.D.	2	1000
Mercury (Hg)	mg/kg	IEC 62321:2008, ICP-OES	N.D.	2	1000
Hexavalent Chromium (CrVI) by	mg/kg	IEC 62321:2008, UV-Vis	N.D.	2	1000
alkaline extraction					
Sum of PBBs	mg/kg	-	N.D.	-	1000
Monobromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Dibromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Tribromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Tetrabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Pentabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Hexabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Heptabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Octabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Nonabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Decabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Sum of PBDEs	mg/kg	-	N.D.	-	1000
Monobromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Dibromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Tribromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Tetrabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Pentabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Hexabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Heptabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Octabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Nonabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Decabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	

Note:

- 1. mg/kg = ppm
- 2. N.D. = Not Detected (< MDL)
- 3. MDL = Method Detection Limit
- 4. "-" = Not regulated

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Annex 2: Analysis Result of Molding Compound (Page 3 of 7)



Test Report No. CANEC1100147901 Date: 17 Jan 2011 Page 3 of 7

B:Elementary Analysis

 Test Item(s)
 Unit
 Test Method (Reference)
 Result
 MDL

 Antimony (Sb)
 mg/kg
 EPA 3052:1996, ICP-OES
 N.D.
 10

Note:

- mg/kg = ppm
- 2. N.D. = Not Detected (< MDL)
- 3. MDL = Method Detection Limit

C:Halogen

Test Item(s)	Unit	Test Method (Reference)	Result	MDL
Fluorine (F)	mg/kg	BS EN 14582:2007, IC	N.D.	50
Chlorine (CI)	mg/kg	BS EN 14582:2007, IC	112	50
Bromine (Br)	mg/kg	BS EN 14582:2007, IC	N.D.	50
lodine (I)	ma/ka	BS EN 14582:2007, IC	N.D.	50

Note:

- 1. mg/kg = ppm
- 2. N.D. = Not Detected (< MDL)
- 3. MDL = Method Detection Limit

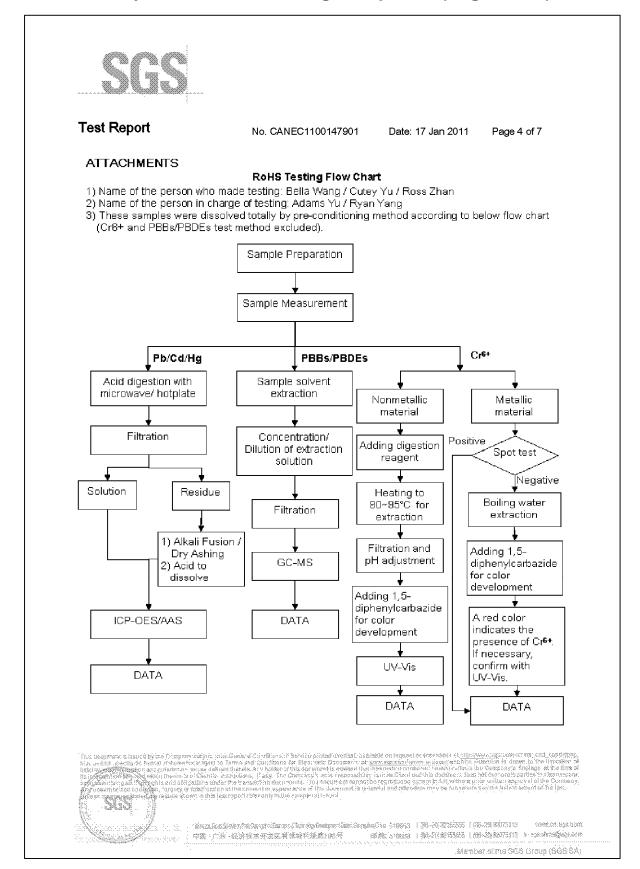
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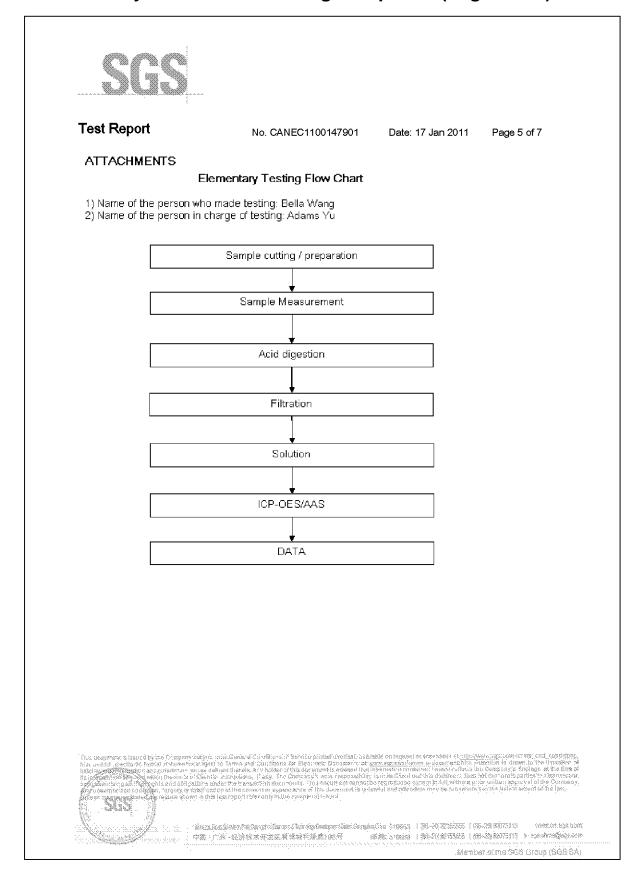


Annex 2: Analysis Result of Molding Compound (Page 4 of 7)



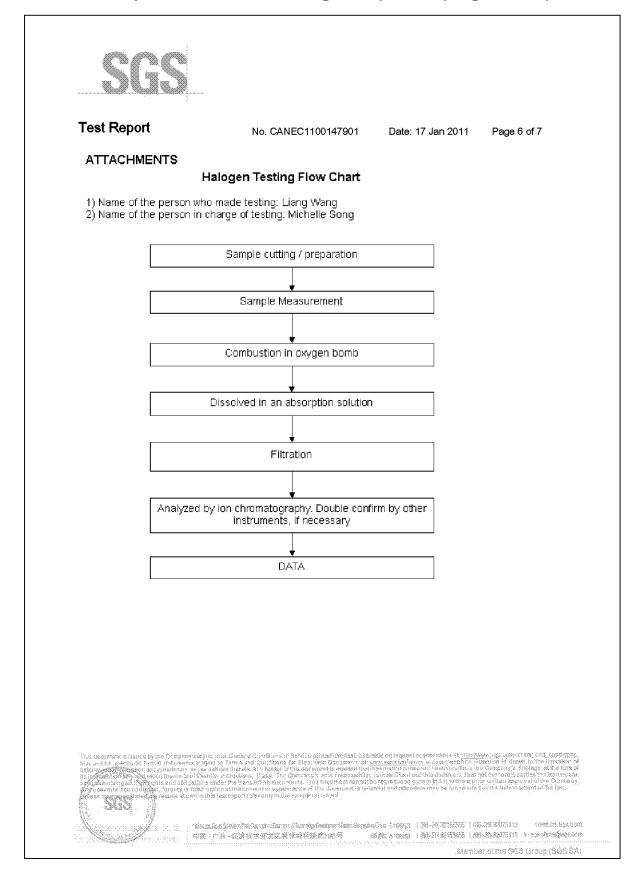


Annex 2: Analysis Result of Molding Compound (Page 5 of 7)





Annex 2: Analysis Result of Molding Compound (Page 6 of 7)





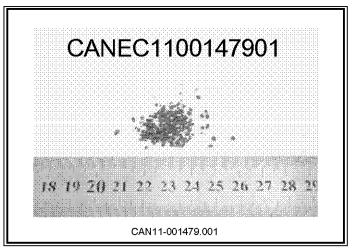
Annex 2: Analysis Result of Molding Compound (Page 7 of 7)

Test ReportNo. CANEC1100147901

Date: 17 Jan 2011

Page 7 of 7

Sample photo:



SGS authenticate the photo on original report only

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Annex 3: Analysis Result of Die-Attach Solder (Page 1 of 6)



Test Report No: 10211878(8) Date: 14-Oct-10 Page 1 of 6

Heraeus Materials Singapore Pte Ltd No. 2 Corporation Road, #06-15/16/17 Corporation Place, Singapore 618494

The following sample(s) was/were submitted and identified by/on behalf of the client as:

PbSn2Ag2.5 Solder Wire Sample Description

Sample Receiving Date 05-Oct-10

Testing Period 07-Oct-10 to 13-Oct-10

In accordance with the RoHS Directive 2002/95/EC, and its amendment Test Requested

Test Result(s) Please refer to next page(s).

Conclusion Based on the performed tests on submitted sample(s), the results comply

with the RoHS Directive 2002/95/EC and its subsequent amendments.

Signed for and on behalf of SGS Testing & Control Services Singapore Pte Ltd

Y.C. Tham

Laboratory Manager

Test Location: 26 Ayer Rajah Crescent, #07-08, Singapore 139944

Iest Location: 26 Ayer Hajah Crescent, #M/-UB, Singapore 139944
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SGS Testing & Control Services Singapore Pte Ltd

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Annex 3: Analysis Result of Die-Attach Solder (Page 2 of 6)



Test Report No: 10211878(8) Date: 14-Oct-10 Page 2 of 6

Test Result(s):

Sample Description PbSn2Ag2.5 Solder Wire

Test Item(s):	Unit	Method	Results	MDL	RoHS Limit
Cadmium(Cd)	mg/kg	With reference to IEC62321, Ed1:2008. Analysis was performed by ICP/AES	n.d.	2	100
Lead (Pb)	mg/kg	With reference to IEC62321, Ed1:2008. Analysis was performed by ICP/AES	661360.7	2	1000
Mercury (Hg)	mg/kg	With reference to IEC62321, Ed1:2008. Analysis was performed by ICP/AES	n.d.	2	1000
Hexavalent Chromium (CrVI) (By spot test / boiling water extraction)		With reference to IEC62321, Ed1:2008 and performed by Spot test / boiling water extraction method. (see Note 9)	Negative	0.02 mg/kg with 50 cm ² surface area	#
Sum of PBBs	mg/kg	,	n.d.	-	1000
Monobromobiphenyl	mg/kg		n.d.	5	-
Dibromobiphenyl	mg/kg		n.d.	5	-
Tribromobiphenyl	mg/kg		n.d.	5	-
Tetrabromobiphenyl	mg/kg		n.d.	5	-
Hexabromobiphenyl	mg/kg		n.d.	5	-
Pentabromobiphenyl	mg/kg		n.d.	5	-
Heptabromobiphenyl	mg/kg		n.d.	5	-
Octabromobiphenyl	mg/kg		n.d.	5	-
Nonabromobiphenyl	mg/kg		n.d.	5	
Decabromobiphenyl	mg/kg	VVILTI reference to IECo2321,	n.d.	5	-
Sum of PBDEs	mg/kg	Ed1:2008. Analysis was	n.d.	-	1000
Monobromodiphenyl ether	ma/ka	performed by GC/MS	n.d.	5	-
Dibromodiphenyl ether	mg/kg		n.d.	5	_
Tribromodiphenyl ether	mg/kg		n.d.	5	_
Tetrabromodiphenyl ether	mg/kg		n.d.	5	-
Pentabromodiphenyl ether	mg/kg		n.d.	5	-
Hexabromodiphenyl ether	mg/kg		n.d.	5	-
Heptabromodiphenyl ether	mg/kg		n.d.	5	-
Octabromodiphenyl ether	mg/kg		n.d.	5	-
Nonabromodiphenyl ether	mg/kg		n.d.	5	-
Decabromodiphenyl ether ##	mg/kg		n.d.	5	-

Test Location: 26 Ayer Rajah Crescent, #07-08, Singapore 139944

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Annex 3: Analysis Result of Die-Attach Solder (Page 3 of 6)



Test Report No: 10211878(8) Date: 14-Oct-10 Page 3 of 6

Note:

- (1) mg/kg = ppm; 0.1wt% = 1000ppm
- (2) n.d.= Not Detected
- (3) MDL = Method Detection Limit
- (4) ## = The exemption of DecaBDE in polymeric application according 2005/717/EC was overruled by the European Court of Justice by its decision of 01.04. $\bar{2}008$. Subsequently DecaBDE will be included in the sum of PBDE after 01.07.2008.
- (5) "-" = Not regulated
- (6) "---": No unit (Qualitative Test)
- (7) * : Exceeds limit
- (8) #: Positive means the presence of CrVI on the tested areas. Negative means the absence of CrVI on the tested areas.
- (9) Spot-test:

Negative = Absence of Cr(VI) coating / surface layer Positive = Presence of Cr(VI) coating / surface layer

The tested sample should be further verified by boiling-water-extraction method if the spot test result cannot be confirmed.

Boiling-water extraction:

Negative = Absence of Cr(VI) coating / surface layer Positive = Presence of Cr(VI) coating / surface layer

the detected concentration in boiling-water-extraction solution is equal or greater

than 0.02 mg/kg with 50 cm2 sample surface area.

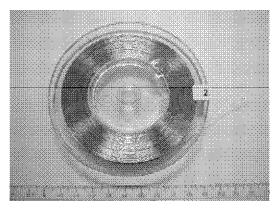
Lab Analyst(s): Jojo and Eileen

Remarks: Sample received was totally dissolved by preconditioning method.

Sample photo:

PbSn2Ag2.5 Solder Wire Sample Description

SGS authenticate the photo on original report only



Test Location: 26 Aver Raiah Crescent, #07-08, Singapore 139944

Test Location: 26 Ayer Rajan Crescent, #UZ-UB, Singapore 13944
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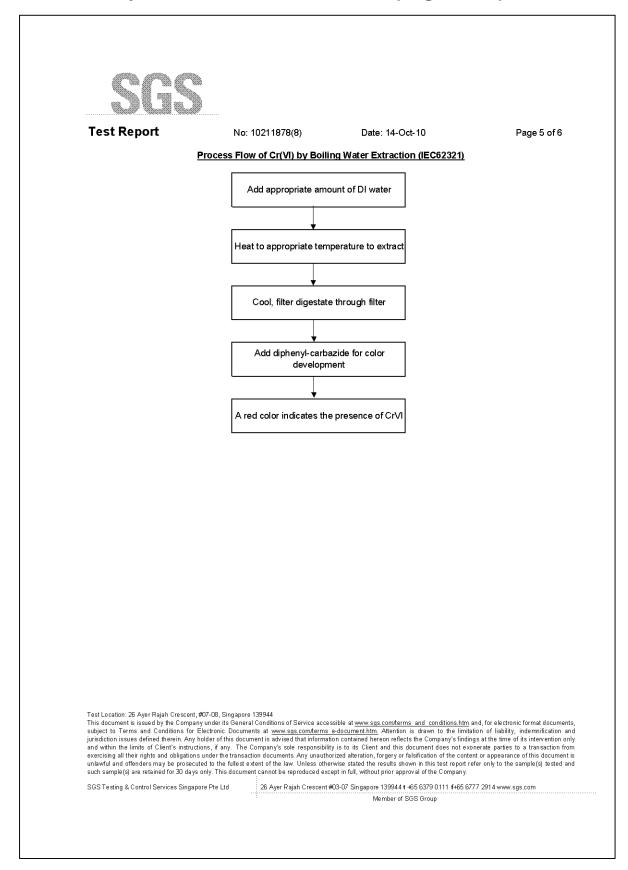
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Annex 3-3 April 27, 2011 Littelfuse, Inc.

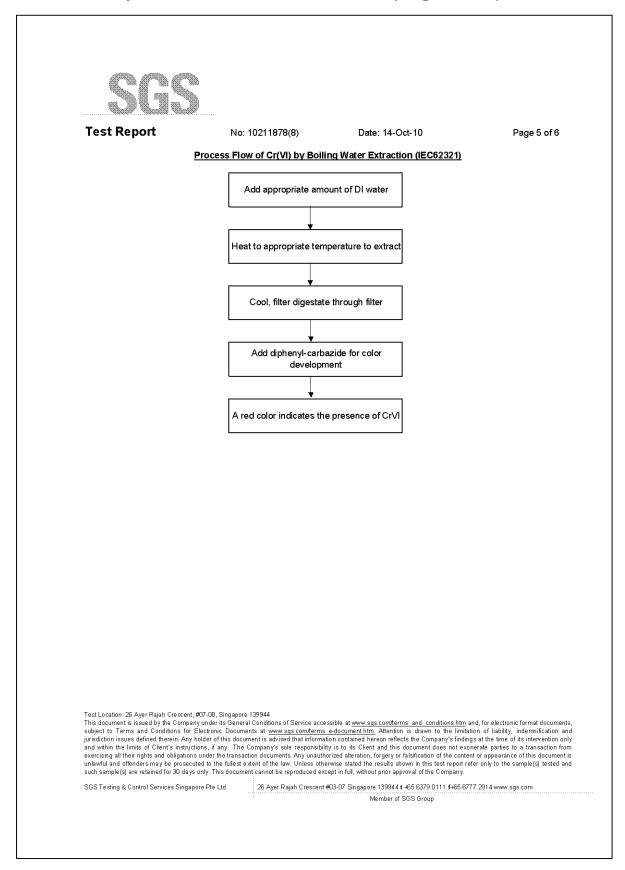


Annex 3: Analysis Result Die-Attach Solder (Page 4 of 6)



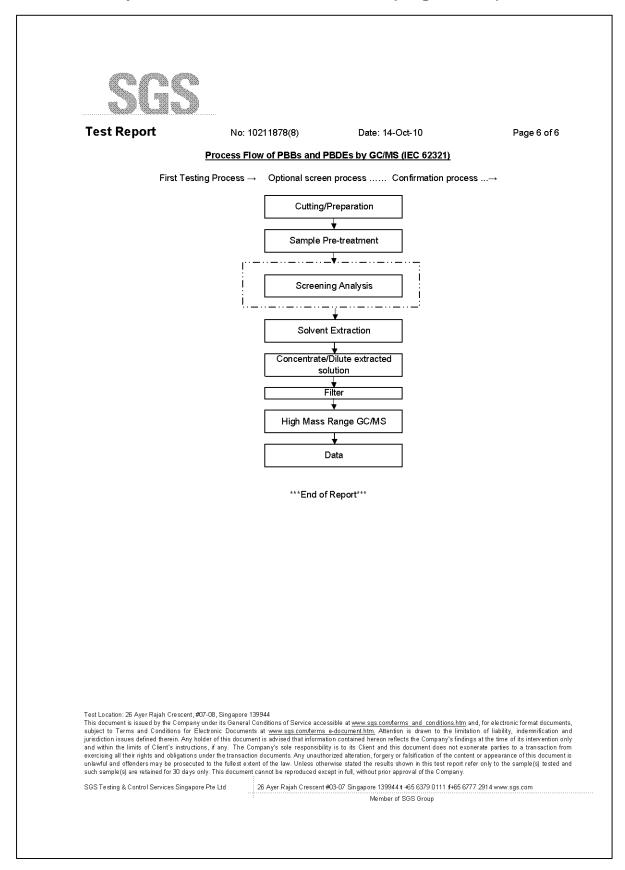


Annex 3: Analysis Result Die-Attach Solder (Page 5 of 6)





Annex 3: Analysis Result Die-Attach Solder (Page 6 of 6)





Annex 4: Analysis Result of Die-bonding Wire (Page 1 of 12)

Validity<u>-u</u>nknown For Question Please Contact with SGS

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Test Report No.: KA/2010/80978A-04 Date: 2010/08/31 Page: 1 of 12

HERAEUS MATERIALS SINGAPORE PTE LTD BLK 5002 ANG MO KIO AVE 5, #04-05 TECHPLACE II, SINGAPORE 569871 The following sample(s) was/were submitted and identified by/on behalf of the client as:

Sample Description Au BONDING WIRE

AW1, AW6, AW7, AW8, AW9, AW13, AW14, AW21, AW22, AW23, Style/Item No.

AW24, AW25, AW28, AW29, AW66/66i/66X, AW99/99i/99X, Formax,

FP2, RADIX, RADIXplus, RelMax

GOLD Color

2010/08/13 Sample Receiving Date Testing Period 2010/08/13 TO 2010/08/31

Test Result(s) Please refer to next page(s).

Ray Chang / Asst. Manage Signed for and on behalf of

SGS Taiwan Limited

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Annex 4: Analysis Result of Die-bonding Wire (Page 2 of 12)



Test Report No.: KA/2010/80978A-04 Date: 2010/08/31 Page: 2 of 12

HERAEUS MATERIALS SINGAPORE PTE LTD BLK 5002 ANG MO KIO AVE 5, #04-05 TECHPLACE II, SINGAPORE 569871

Test Result(s)

PART NAME NO.1 Au BONDING WIRE

Test Item (s):	Unit	Method	MDL	Result
Cadmium (Cd)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES.	2	No.1 n.d.
Lead (Pb)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES.	2	n.d.
Mercury (Hg)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES.	2	n.d.
Hexavalent Chromium Cr(VI) by Spot test / boiling water extraction	**	With reference to IEC 62321: 2008 and performed by Spot test / boiling water extraction Method. (See Note 5)	0.02mg/kg with 50 cm² surface area	Negative
Hexavalent Chromium Cr(VI)	mg/kg	With reference to US EPA Method 3060A & 7196A for Hexavalent Chromium. Analysis was performed by UV-Vis Spectrometry.	2	n.d.
Antimony (Sb)	mg/kg	With reference to US EPA Method 3052 for Antimony Content. Analysis was performed by ICP-AES.	2	n.d.
Perfluorooctane sulfonates (PFOS) PFOS – Acid PFOS – Metal Salt PFOS – Amide	mg/kg	With reference to US EPA 3540C: 1996 method for PFOS Content. Analysis was performed by LC/MS.	10	n.d.
PFOA (CAS No.: 000335-67-1)	mg/kg	With reference to US EPA 3540C: 1996 method for PFOA Content. Analysis was performed by LC/MS.	10	n.d.

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Annex 4: Analysis Result of Die-bonding Wire (Page 3 of 12)



Test Report No.: KA/2010/80978A-04 Date: 2010/08/31 Page: 3 of 12

HERAEUS MATERIALS SINGAPORE PTE LTD

BLK 5002 ANG MO KIO AVE 5, #04-05 TECHPLACE II, SINGAPORE 569871

Test Item (s):	Unit	Method	MDL	Result	
` '		11100100		No.1	
Sum of PBBs]		-	n.d.	
Monobromobiphenyl]		5	n.d.	
Dibromobiphenyl	mg/kg mg/kg mg/kg mg/kg		5	n.d.	
Tribromobiphenyl			5	n.d.	
Tetrabromobiphenyl) A 5th 5 to 150 00001 0000 I	5	n.d.	
Pentabromobiphenyl	mg/kg	With reference to IEC 62321: 2008 and performed by GC/MS.	5	n.d.	
Hexabromobiphenyl]	performed by Convice.	5	n.d.	
Heptabromobiphenyl]		5	n.d.	
Octabromobiphenyl	1		5	n.d.	
Nonabromobiphenyl	1		5	n.d.	
Decabromobiphenyl	1		5	n.d.	
Sum of PBDEs			-	n.d.	
Monobromodiphenyl ether			5	n.d.	
Dibromodiphenyl ether		With reference to IEC 62321: 2008 and performed by GC/MS.	5	n.d.	
Tribromodiphenyl ether	1		5	n.d.	
Tetrabromodiphenyl ether	1		5	n.d.	
Pentabromodiphenyl ether	mg/kg		5	n.d.	
Hexabromodiphenyl ether	1		5	n.d.	
Heptabromodiphenyl ether	1		5	n.d.	
Octabromodiphenyl ether	1		5	n.d.	
Nonabromodiphenyl ether	1		5	n.d.	
Decabromodiphenyl ether	1		5	n.d.	
Halogen					
Halogen-Fluorine (F) (CAS No.: 014762-94-8)	mg/kg	With reference to BS EN 14582:2007. Analysis was performed by IC.	50	n.d.	
Halogen-Chlorine (CI) (CAS No.: 022537-15-1)	mg/kg	With reference to BS EN 14582:2007. Analysis was performed by IC.	50	n.d.	
Halogen-Bromine (Br) (CAS No.: 010097-32-2)	mg/kg	With reference to BS EN 14582:2007. Analysis was performed by IC.	50	n.d.	
Halogen-lodine (I) (CAS No.: 014362- 44-8)	mg/kg	With reference to BS EN 14582:2007. Analysis was performed by IC.	50	n.d.	



Annex 4: Analysis Result of Die-bonding Wire (Page 4 of 12)



Test Report No.: KA/2010/80978A-04 Date: 2010/08/31 Page: 4 of 12

HERAEUS MATERIALS SINGAPORE PTE LTD BLK 5002 ANG MO KIO AVE 5, #04-05 TECHPLACE II, SINGAPORE 569871

Test Item (s):	Unit	Method	MDL	Result
Phthalates				No.1
BBP (Benzyl butyl phthalate) (CAS No.: 000085-68-7)	%	With reference to EN 14372. Analysis was performed by GC/MS.	0.003	n.d.
DBP (Dibutyl phthalate) (CAS No.: 000084-74-2)	%	With reference to EN 14372. Analysis was performed by GC/MS.	0.003	n.d.
DEHP (Di- (2-ethylhexyl) phthalate) (CAS No.: 000117-81-7)	%	With reference to EN 14372. Analysis was performed by GC/MS.	0.003	n.d.
DIDP (Di-isodecyl phthalate) (CAS No.: 026761-40-0)	%	With reference to EN 14372. Analysis was performed by GC/MS.	0.01	n.d.
DINP (Di-isononyl phthalate) (CAS No.: 028553-12-0)	%	With reference to EN 14372. Analysis was performed by GC/MS.	0.01	n.d.
DNOP (Di-n-octyl phthalate) (CAS No.: 000117-84-0)	%	With reference to EN 14372. Analysis was performed by GC/MS.	0.003	n.d.
DNHP (Di-n-hexyl phthalate) (CAS No.: 000084-75-3)	%	With reference to EN 14372. Analysis was performed by GC/MS.	0.003	n.d.
DMEP (Bis (2-methoxyethyl) phthalate) (CAS No.: 000117-82-8)	%	With reference to EN 14372. Analysis was performed by GC/MS.	0.003	n.d.

Note: 1. mg/kg = ppm: 0.1wt% = 1000ppm

2. n.d. = Not Detected

3. MDL = Method Detection Limit

4. " - " = Not Regulated

5. Spot-test:

Negative = Absence of Cr(VI) coating / surface layer,

Positive = Presence of Cr(VI) coating / surface layer;

(The tested sample should be further verified by boiling-water-extraction method if the

spot test result cannot be confirmed.)

Boiling-water-extraction:

Negative = Absence of Cr(VI) coating / surface layer.

Positive = Presence of Cr(VI) coating / surface layer;

the detected concentration in boiling-water-extraction solution is equal or greater

than 0.02 mg/kg with 50 cm² sample surface area.

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Annex 4: Analysis Result of Die-bonding Wire (Page 5 of 12)



Test Report No.: KA/2010/80978A-04 Date: 2010/08/31 Page: 5 of 12

HERAEUS MATERIALS SINGAPORE PTE LTD

- 6. ** = Qualitative analysis (No Unit)
- 7. This is the additional test report of KA/2010/80978 which was issued on 2010/08/31. Please refer to KA/2010/80978 for original information.

PFOS Reference Information : Directive 2006/122/EC

- (1) May not be placed on the market or used as a substance or constituent of preparations in a concentration equal to or higher than 0.005 % by mass.
- (2) May not be placed on the market in semi-finished products or articles, or parts thereof, if the concentration of PFOS is equal to or higher than 0.1 % by mass calculated with reference to the mass of structurally or microstructurally distinct parts that contain PFOS or, for textiles or other coated materials, if the amount of PFOS is equal to or higher than 1µg/m² of the coated material.

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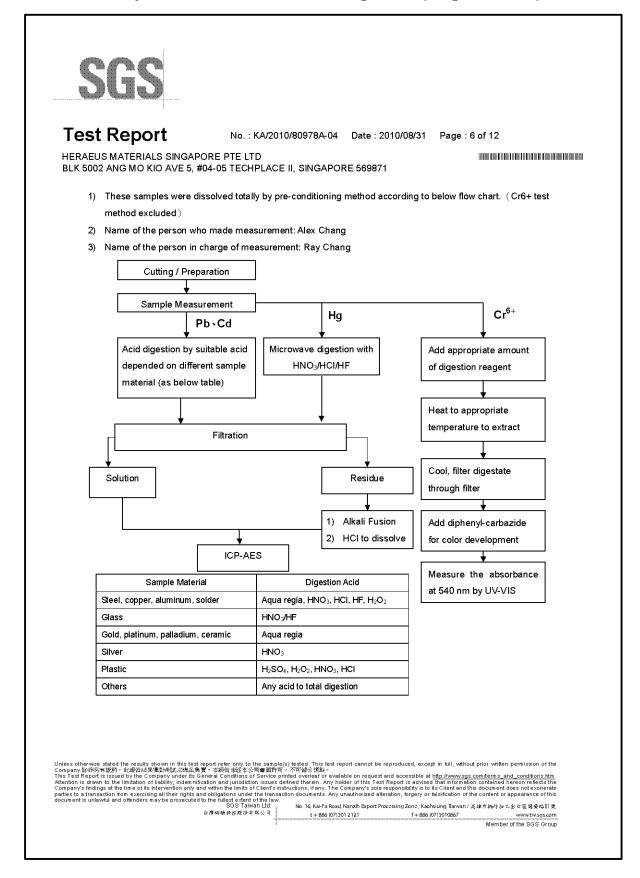
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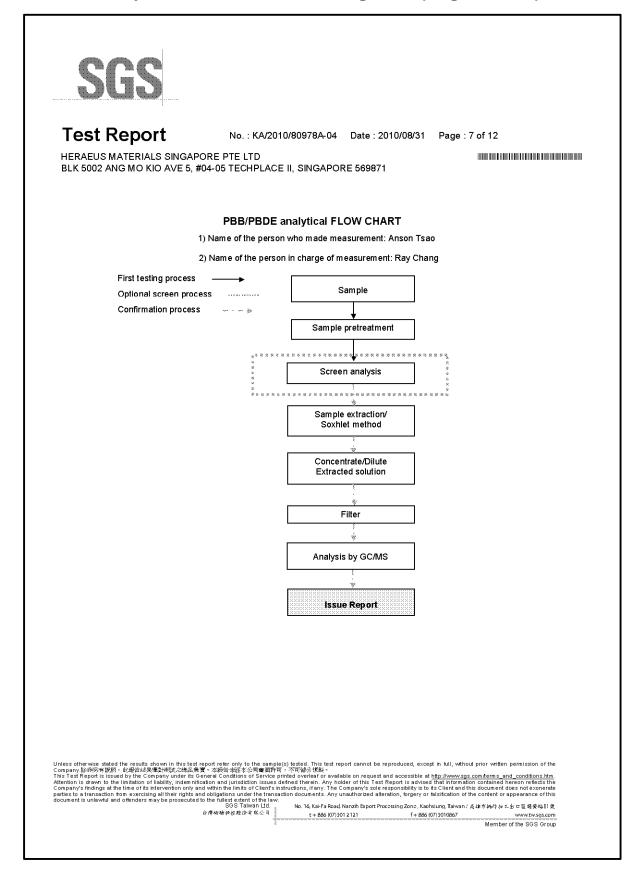


Annex 4: Analysis Result of Die-bonding Wire (Page 6 of 12)





Annex 4: Analysis Result of Die-bonding Wire (Page 7 of 12)





Annex 4: Analysis Result of Die-bonding Wire (Page 8 of 12)



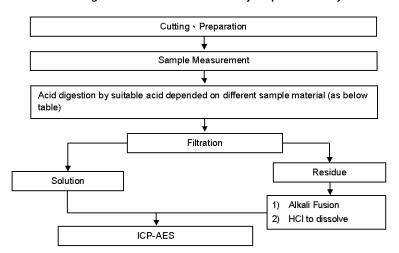
Test Report

No.: KA/2010/80978A-04 Date: 2010/08/31 Page: 8 of 12

HERAEUS MATERIALS SINGAPORE PTE LTD BLK 5002 ANG MO KIO AVE 5, #04-05 TECHPLACE II, SINGAPORE 569871

- 1) These samples were dissolved totally by pre-conditioning method according to below flow chart.
- 2) Name of the person who made measurement: Alex Changi
- 3) Name of the person in charge of measurement: Ray Chang

Flow Chart of digestion for the elements analysis performed by ICP-AES



Steel, copper, aluminum, solder	Aqua regia, HNO 3, HCl, HF, H2O2
Glass	HNO₃/HF
Gold, platinum, palladium, ceramic	Aqua regia
Silver	HNO ₃
Plastic	H ₂ SO ₄ , H ₂ O ₂ , HNO ₃ , HCI
Others	Any acid to total digestion

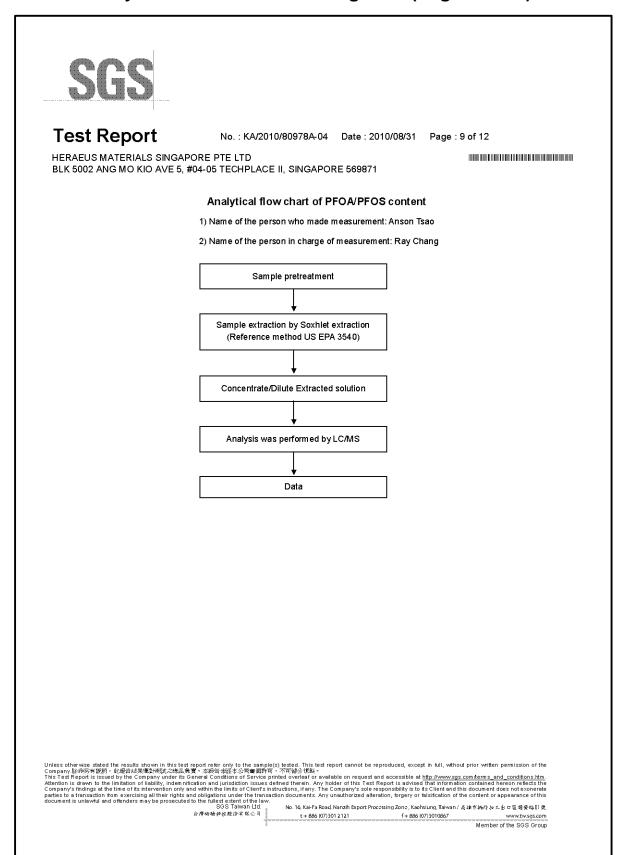
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Annex 4-8 April 27, 2011 Littelfuse, Inc.

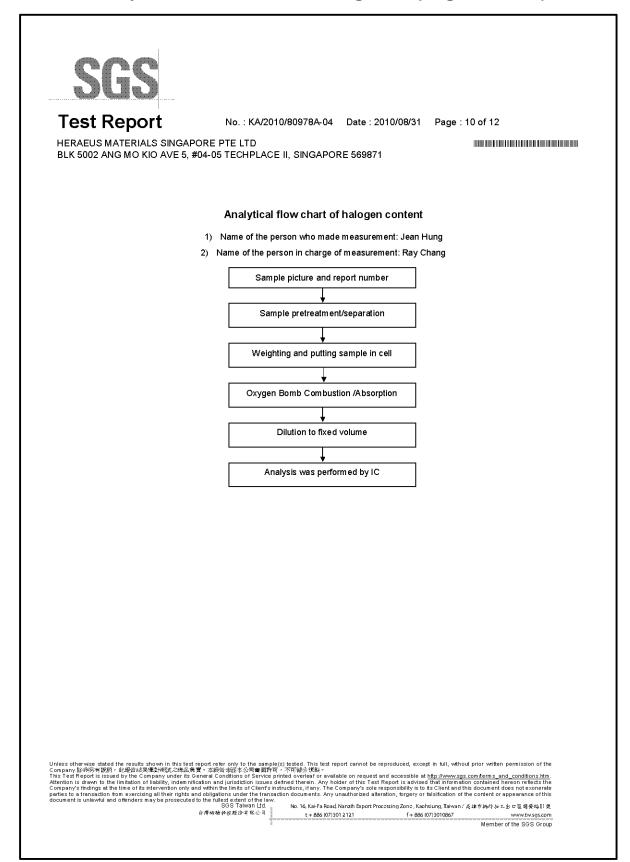


Annex 4: Analysis Result of Die-bonding Wire (Page 9 of 12)



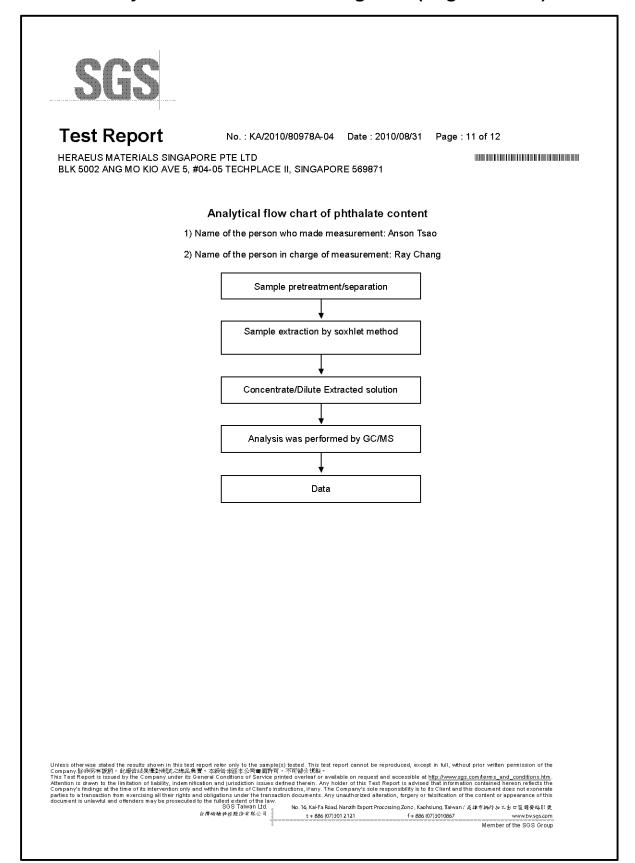


Annex 4: Analysis Result of Die-bonding Wire (Page 10 of 12)





Annex 4: Analysis Result of Die-bonding Wire (Page 11 of 12)





Annex 4: Analysis Result of Die-bonding Wire (Page 12 of 12)



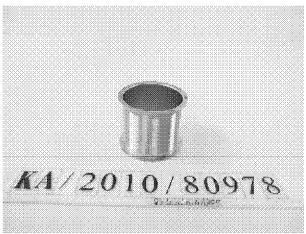
Test Report

No.: KA/2010/80978A-04 Date: 2010/08/31 Page: 12 of 12

HERAEUS MATERIALS SINGAPORE PTE LTD BLK 5002 ANG MO KIO AVE 5, #04-05 TECHPLACE II, SINGAPORE 569871







** End of Report **

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Annex 4-12 April 27, 2011 Littelfuse, Inc.



Annex 5: Analysis Result of Lead Frame (page 1 of 11)



Test Report No. 2107721/EC Date: Jan 25 2011 Page 1 of 11

LEADFRAME TECHNOLOGY LIMITED UNIT 04, G/F., LAI SUN YUEN LONG CENTRE 21 - 35 WANG YIP STREET EAST YUEN LONG N.T., HONG KONG

The following sample was submitted and identified on behalf of the applicant as: LEADFRAME MADE OF COPPER ALLOY A194

SGS Job No. : 1436616
Lot No. : 110113
Manufacturer : LEADFRAME TECHNOLOGY LIMITED
Country of Origin : HONG KONG
Sample Receiving Date : JAN 14 2011
Testing Period : JAN 14 - 25 2011

Test Requested: Selected test (s) as requested by client.

Test Method Please refer to next page(s).

Test Results Please refer to next page(s).

Conclusion 1) Based on the performed tests on submitted sample, the results comply with

the RoHS Directive 2002/95/EC and its subsequent amendments.

4) When tested as specified, the submitted sample complies with the phthalate requirements under entries 51 and 52 of the Regulation (EC) No. 552/2009 amending Annex XVII of REACH Regulation (EC) No. 1907/2006 (previously

restricted under Directive 2005/84/EC).

Signed for and on behalf of SGS Hong Kong Ltd

Thu Hung Yat, Rodney Section Manager

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Annex 5: Analysis Result of Lead Frame (page 2 of 11)



Test Report No. 2107721/EC Date: Jan 25 2011 Page 2 of 11

Test result:

1)

ID for sample 1 : 4120954002

Description for sample 1 : Metal w/ Silvery Plating (Base: Coppery Metal)

RoHS Directive 2002/95/EC

Test Item(s):	Unit	Test Method	Results	<u>MDL</u>	<u>Limit</u>
Cadmium(Cd)	mg/kg	With reference to IEC 62321:2008 and performed by ICP-OES	n.d.	2	100
Lead (Pb)	mg/kg	With reference to IEC 62321:2008 and performed by ICP-OES	16	5	1000
Mercury (Hg)	mg/kg	With reference to IEC 62321:2008 and performed by ICP-OES	n.d.	2	1000
Hexavalent Chromium (CrVI) by spot-test/ boiling-water-extraction	-	With reference to IEC 62321:2008	Negative	-	#
Sum of PBBs	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	-	1000
Monobromobiphenyl	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Dibromobiphenyl	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Tribromobiphenyl	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Tetrabromobiphenyl	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Pentabromobiphenyl	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Hexabromobiphenyl	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Heptabromobiphenyl	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Octabromobiphenyl	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Nonabromobiphenyl	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Decabromobiphenyl	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	

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Annex 5: Analysis Result of Lead Frame (page 3 of 11)

No. 2107721/EC



Test Report

•				0	
Sum of PBDEs	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	_ 100	0
Monobromodiphenyl ether	mg/kg	With reference to IEĆ 62321:2008 and performed by GC-MS	n.d.	5	
Dibromodiphenyl ether	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Tribromodiphenyl ether	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Tetrabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Pentabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Hexabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Heptabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Octabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Nonabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	
Decabromodiphenyl ether ##	mg/kg	With reference to IEC 62321:2008 and performed by GC-MS	n.d.	5	

Date: Jan 25 2011

Page 3 of 11

Note:

- (1) mg/kg = ppm; 0.1wt% = 1000 ppm
- (2) n.d. = not detected
- (3) MDL = Method Detection Limit
- (4) ## = The exemption of DecaBDE in polymeric application according 2005/717/EC was overruled by the European Court of Justice by its decision of 01.04.2008. Subsequently DecaBDE will be included in the sum of PBDE after 01.07.2008
- (5) # = Negative means the absence of CrVI on the tested areas; Positive means the presence of CrVI on the tested areas. The detected concentration in boiling water extraction solution is equal to or greater than 0.02 mg/kg with 50 cm² sample surface area
- (6) " " = Not regulated

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Annex 5: Analysis Result of Lead Frame (page 4 of 11)



Test Report No. 2107721/EC Date: Jan 25 2011 Page 4 of 11

Test result:

2)

ID for sample 1 : 4120954002

Description for sample 1 : Metal w/ Silvery Plating (Base: Coppery Metal)

PFOS (Perfluorooctane sulfonates)

Test Item(s)	<u>Unit</u>	Test Method (Reference)	<u>1</u>	<u>MDL</u>
Perfluorooctane sulphonates (PFOS) PFOS – Acid PFOS – Metal Salt PFOS – Amide	mg/kg	With reference to SGS in- house method and performed by HPLC-MS	n.d.	10
PFOA (Perfluorooctyl Acid)				
Test Item(s)	Unit	Test Method (Reference)	1	MDI

Perfluorooctyl Acid (PFOA) mg/kg With reference to SGS inhouse method and n.d. 10

performed by HPLC-MS

Note:

(1) mg/kg = ppm

- (2) n.d. = Not Detected (< MDL)
- (3) MDL = Method Detection Limit

Reference information: Entry 53 of the Regulation (EC) No. 552/2009 amending Annex XVII of REACH Regulation (EC) No. 1907/2006 (Formerly Directive 2006/122/EC).

- (1) Shall not be placed on the market, or used, as a substance or in mixtures in concentrations equal to or higher than 0,005% by mass.
- (2) Shall not be placed on the market in semi-finished products or articles, or parts thereof, if the concentration of PFOS is equal to or higher than 0,1% by mass calculated with reference to the mass of structurally or microstructurally distinct parts that contain PFOS or, for textiles or other coated materials, if the amount of PFOS is equal to or higher than 1μg/m² of the coated material.

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Annex 5: Analysis Result of Lead Frame (page 5 of 11)

S(GS)

Test Report No. 2107721/EC Date: Jan 25 2011 Page 5 of 11

Test result:

3)

ID for sample 1 : 4120954002

Description for sample 1 : Metal w/ Silvery Plating (Base: Coppery Metal)

HBCDD

Test Item(s): Unit Test Method Results $\underline{\text{MDL}}$ HBCDD mg/kg With reference to US EPA3550C:2007, and n.d. 5

performed by GC-MS

Note:

(1) mg/kg = ppm; 0.1wt% = 1000 ppm

(2) n.d. = not detected

(3) MDL = Method Detection Limit

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Annex 5: Analysis Result of Lead Frame (page 6 of 11)



Test Report No. 2107721/EC Date: Jan 25 2011 Page 6 of 11

Test results:

4)

ID for sample 1 : 4120954002

Description for sample 1 : Metal w/ Silvery Plating (Base: Coppery Metal)

Phthalate

Test item <u>DL</u> <u>Limit</u> Test Method <u>1</u> ASTM Method Designation Dibutyl Phthalate 0.003% (DBP) D3421-75, GC-MS n.d. ASTM Method Designation Benzylbutyl Phthalate 0.003% (BBP) D3421-75, GC-MS n.d. ASTM Method Designation Bis-(2-ethylhexyl) Phthalate 0.003% (DEHP) D3421-75, GC-MS n.d. Total (DBP + BBP + DEHP) <0.01% 0.1%

Note:

- (1) mg/kg = ppm; 0.1% = 1000 ppm
- (2) DL = Detection Limit
- (3) n.d. = Not Detected (Less than DL)
- (4) < = less than
- (5) % = percentage by weight
- (6) -= Not Regulated

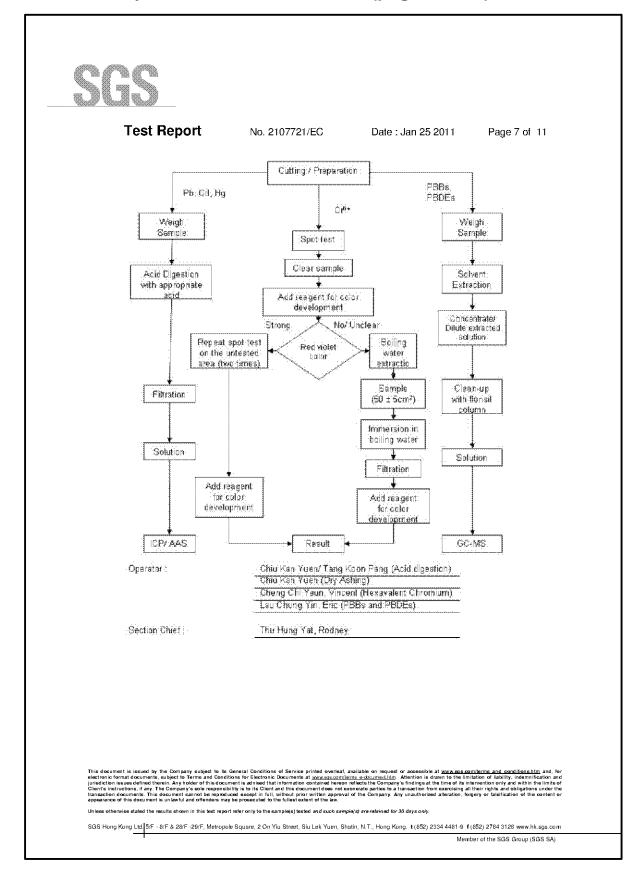
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Annex 5: Analysis Result of Lead Frame (page 7 of 11)



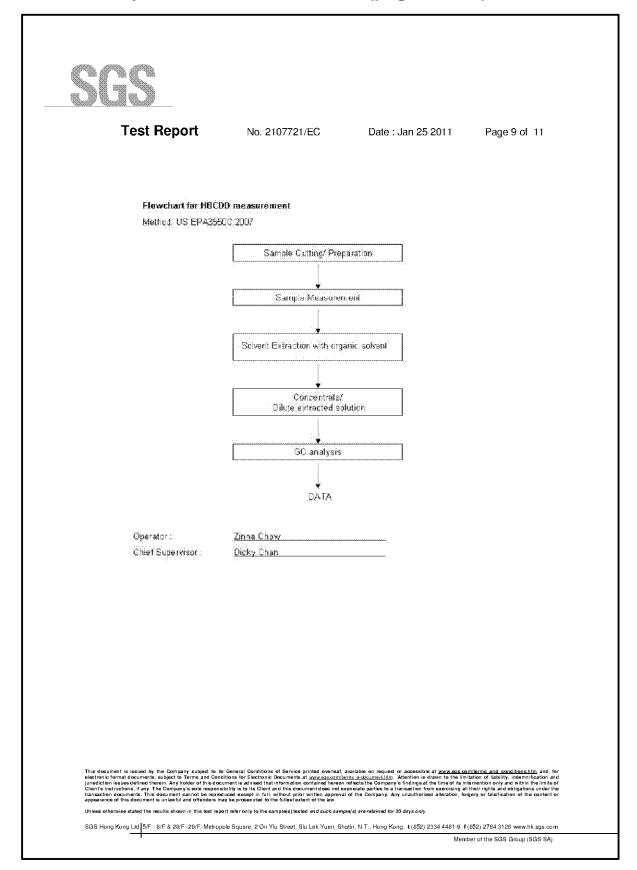


Annex 5: Analysis Result of Lead Frame (page 8 of 11)

Test Report	No. 2107721/EC	Date : Jan 25 2011	Page 8 of 11
Flowchart for PFOS Method: In-House ma	V PFOA measurement offined		
	Sample Cutting/ Pre	raisation	
	Solveni Extraction in autor extractor	rated sugided	
		in against an against an against an against an against an against against against an against against against a	
	Pre-concentration of samp re-classive in Mi	ie, extractant/ OH	
	HPLC/ MS analy	min'	
	in tex tex carety	334 D	
	ÖATA		
Operator :	Candy Luk		
Chief Supervisor:	YuKaLsi		

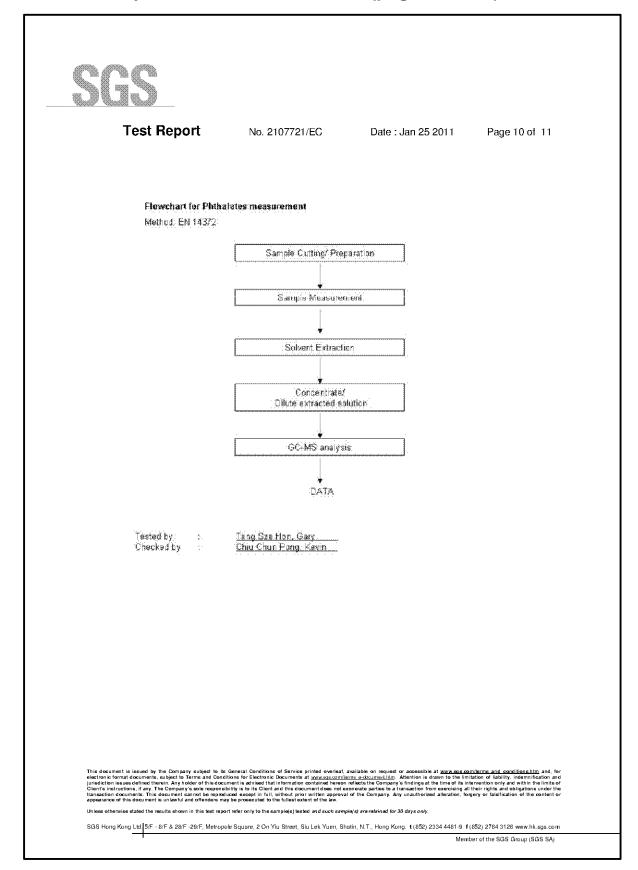


Annex 5: Analysis Result of Lead Frame (page 9 of 11)





Annex 5: Analysis Result of Lead Frame (page 10 of 11)



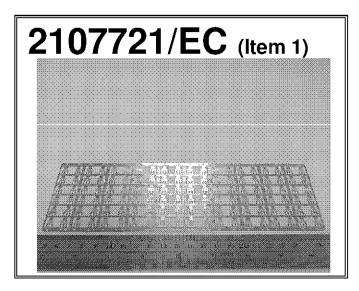


Annex 5: Analysis Result of Lead Frame (page 11 of 11)



Test Report No. 2107721/EC Date: Jan 25 2011 Page 11 of 11

Sample photo:



SGS authenticate the photo on original report only

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Annex 6: Analysis Result of Silicon Wafer (Page 1 of 7)



Validity unknown Please Contact with SGS www.tw.sgscom

Test Report No.: CE/2010/B2372 Date: 2010/11/18 Page: 1 of 7

LITE-ON SEMICONDUCTOR CORP. 28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN The following sample(s) was/were submitted and identified by/on behalf of the client as:

Sample Description : WAFER Style/Item No. : THYRISTOR Sample Receiving Date : 2010/11/11

Testing Period : 2010/11/11 TO 2010/11/18

: Please refer to next page(s). Test Result(s)

Chenyu Kung Signed for and on behalf on SGS TAIWAN LTD. Chemical Laboratory - Taipel

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Annex 6: Analysis Result of Silicon Wafer (Page 2 of 7)



Test Report No.: CE/2010/B2372 Date: 2010/11/18 Page: 2 of 7

LITE-ON SEMICONDUCTOR CORP. 28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN

Test Result(s)

PART NAME No.1 : WAFER

Test Item (s):	Unit	Method	MDL	Result
rest item (s):	Unit	Wethod	MDL	No.1
Cadmium (Cd)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES.	2	n.d.
Lead (Pb)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES.	2	19200
Mercury (Hg)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES.	2	n.d.
Hexavalent Chromium Cr(VI) by alkaline extraction	mg/kg	With reference to IEC 62321: 2008 and performed by UV-VIS.	2	n.d.
Sum of PBBs			-	n.d.
Monobromobiphenyl	1		5	n.d.
Dibromobiphenyl	1		5	n.d.
Tribromobiphenyl	1	With reference to IEC 62321: 2008 and performed by GC/MS.	5	n.d.
Tetrabromobiphenyl	1		5	n.d.
Pentabrom obiphenyl	1		5	n.d.
Hexabromobiphenyl			5	n.d.
Heptabromobiphenyl			5	n.d.
Octabrom obiphenyl			5	n.d.
Nonabromobiphenyl	1		5	n.d.
Decabrom obiphenyl]		5	n.d.
Sum of PBDEs	mg/kg		-	n.d.
Monobromodiphenyl ether	_		5	n.d.
Dibromodiphenyl ether			5	n.d.
Tribromodiphenyl ether			5	n.d.
Tetrabromodiphenyl ether			5	n.d.
Pentabromodiphenyl ether			5	n.d.
Hexabromodiphenyl ether]		5	n.d.
Heptabromodiphenyl ether			5	n.d.
Octabromodiphenyl ether			5	n.d.
Nonabromodiphenyl ether			5	n.d.
Decabromodiphenyl ether			5	n.d.

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Annex 6: Analysis Result of Silicon Wafer (Page 3 of 7)



Test Report No.: CE/2010/B2372 Date: 2010/11/18 Page: 3 of 7

LITE-ON SEMICONDUCTOR CORP. 28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN

Test Item (s):	Unit	Method	MDL	Result No.1
Halogen				
Halogen-Fluorine (F) (CAS No.: 014762-94-8)		With reference to BS EN 14582:2007.	50	n.d.
Halogen-Chlorine (CI) (CAS No.: 022537-15-1)			50	n.d.
Halogen-Bromine (Br) (CAS No.: 010097-32-2)	mg/kg	Analysis was performed by IC.	50	n.d.
Halogen-lodine (I) (CAS No.: 014362-44-8)			50	n.d.

Note:

1. mg/kg = ppm ; 0.1wt% = 1000ppm

2. n.d. = Not Detected

3. MDL = Method Detection Limit

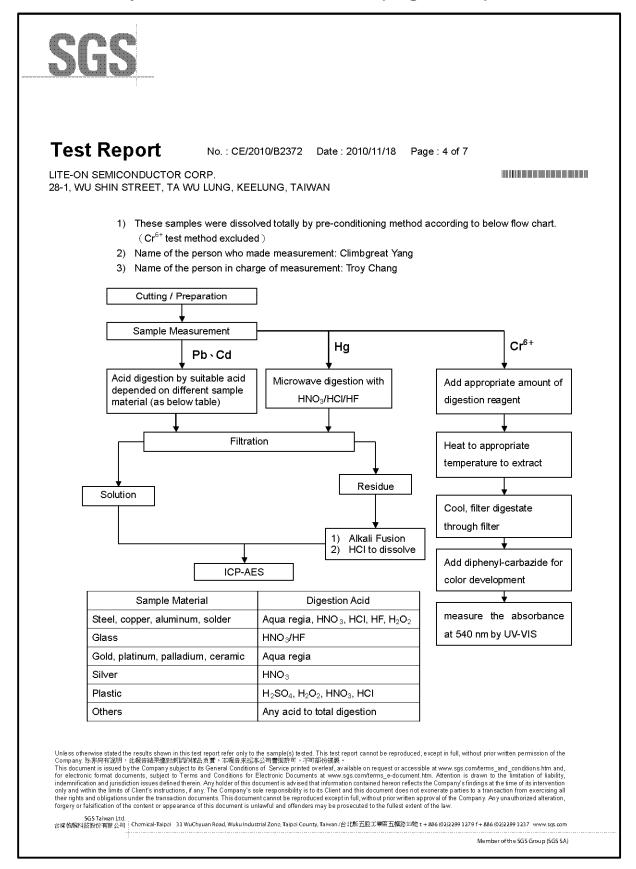
4. " - " = Not Regulated

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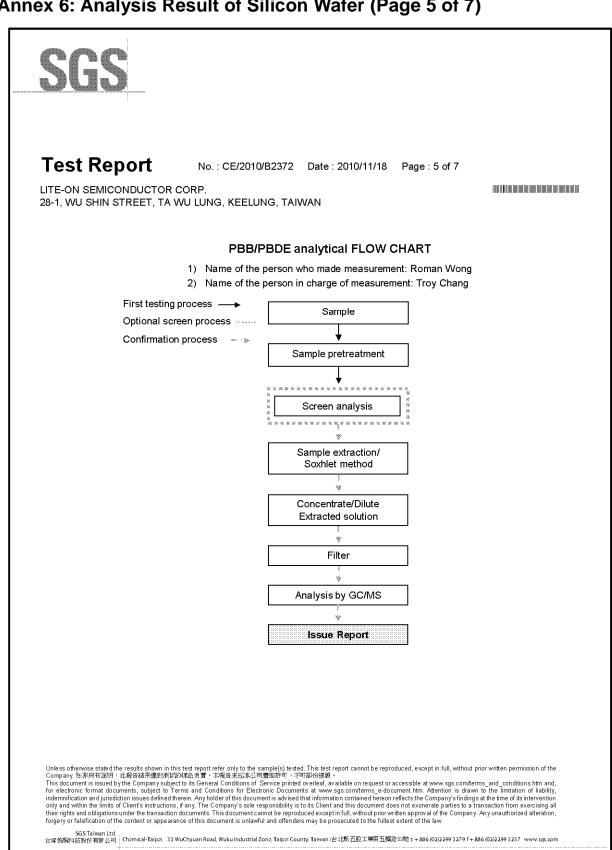


Annex 6: Analysis Result of Silicon Wafer (Page 4 of 7)





Annex 6: Analysis Result of Silicon Wafer (Page 5 of 7)



Annex 6-5 April 27, 2011 Littelfuse, Inc.



Annex 6: Analysis Result of Silicon Wafer (Page 6 of 7)



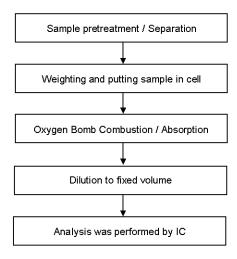
Test Report

No.: CE/2010/B2372 Date: 2010/11/18 Page: 6 of 7

LITE-ON SEMICONDUCTOR CORP. 28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN

Analytical flow chart of halogen content

- 1) Name of the person who made measurement: Rita Chen
- 2) Name of the person in charge of measurement: Troy Chang



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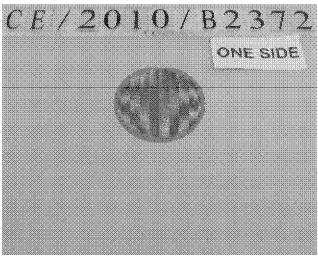


Annex 6: Analysis Result of Silicon Wafer (Page 7 of 7)



Test Report No.: CE/2010/B2372 Date: 2010/11/18 Page: 7 of 7

LITE-ON SEMICONDUCTOR CORP. 28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN





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Annex 7: Applicable RoHS exemptions

	13.2,2003 EN	Official Journ	nal of the European Union	L 37/19
		of 2	ROPEAN PARLIAMENT AND OF THE COUNCIL 27 January 2003 ardous substances in electrical and electronic equipment	
13	i.2.2003 EN	Official Journal of	to be protected and an overall strategy that it	n particular
	Article 4		restricts the use of cadmium and stimulates re substitutes should therefore be implemented.	search into
	Prevention			
con bro (PE the we add	Member States shall ensure that ectrical and electronic equipment puntain lead, mercury, cadmium, hexominated biphenyls (PBB) or polybrabbb. National measures restricting see substances in electrical and electre adopted in line with Communication of this Directive may be 1006.	r on the market does not avalent chromium, poly- minated diphenyl ethers or prohibiting the use of tronic equipment which ty legislation before the		
13.2.2 2.	Paragraph 1 shall not apply to c Annex.	the applications listed in	of the European Union	L 37/23
	Applications of lead, mercur		ent chromium, which are exempted from the requirem	ents
		(71 1	II CICAC I(I)	
	Mercury in compact fluore			
	Mercury in compact fluore Mercury in straight fluores	scent lamps not exceeding	5 mg per lamp.	
	• •	scent lamps not exceeding	5 mg per lamp.	
	2. Mercury in straight fluores	scent lamps not exceeding	g 5 mg per lamp. rposes not exceeding:	
	Mercury in straight fluores halophosphate	escent lamps not exceeding cent lamps for general pur nal lifetime	g 5 mg per lamp. rposes not exceeding: 10 mg	
	Mercury in straight fluores halophosphate triphosphate with nort	scent lamps not exceeding cent lamps for general pur nal lifetime lifetime	g 5 mg per lamp. rposes not exceeding: 10 mg 5 mg 8 mg.	
	Mercury in straight fluores halophosphate triphosphate with nort triphosphate with long	scent lamps not exceeding cent lamps for general put nal lifetime lifetime cent lamps for special pur	g 5 mg per lamp. 10 mg 5 mg 8 mg.	
	2. Mercury in straight fluores — halophosphate — triphosphate with nore — triphosphate with long 3. Mercury in straight fluores	escent lamps not exceeding cent lamps for general pur nal lifetime lifetime cent lamps for special pur of specifically mentioned in	g 5 mg per lamp. 10 mg 5 mg 8 mg. poses. n this Annex.	
	2. Mercury in straight fluores — halophosphate — triphosphate with nore — triphosphate with long 3. Mercury in straight fluores 4. Mercury in other lamps no 5. Lead in glass of cathode ra	escent lamps not exceeding cent lamps for general put nal lifetime lifetime cent lamps for special pur of specifically mentioned in y tubes, electronic compo- nt in steel containing up to	g 5 mg per lamp. 10 mg 5 mg 8 mg. poses. n this Annex. nents and fluorescent tubes. 10 0,35 % lead by weight, aluminium containing up to 0.4 %	leaď
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